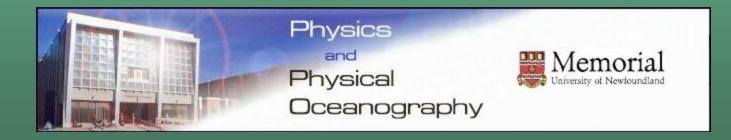
Polarized-neutron Reflectometry from Magnetic Multilayered Films

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Outline

- Neutron Scattering
 - Basic Theory
- Polarized-neutron Specular Reflectometry (PNR)
 - Typical Experimental Setup
- Magnetic Multilayered Films
 - GaMnAs/GaAs superlattices
 - Fe/Cr superlattices

Neutron Scattering

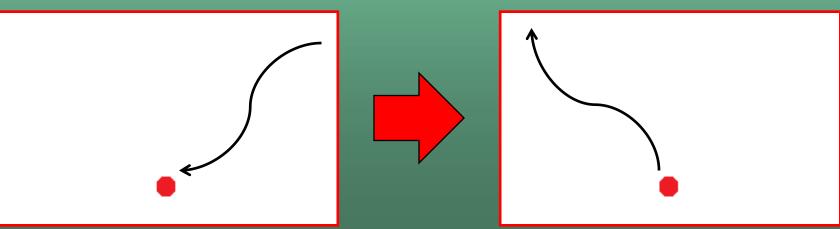
- Neutrons interact with atomic nuclei and magnetic field
- Thermal neutron (λ ~10⁻¹⁰ m) incident on a nucleus ($r_{nucleus}$ ~10⁻¹⁵ m)

$$\left[-\frac{\hbar^2}{2m_{\rm n}}\nabla^2\Psi_{\rm n}+V_{total}\left(\mathbf{r}\right)\right]\Psi_{\rm n}\left(\mathbf{r}\right)=E\Psi_{\rm n}\left(\mathbf{r}\right)$$

$$V_{total}\left(\mathbf{r}\right) \approx V_{n} + V_{m}$$

$$V_n\left(\mathbf{r}\right) = \frac{2\pi\hbar^2}{m_{\rm n}} b_n \delta\left(\mathbf{r}\right) \qquad \qquad V_m\left(\mathbf{r}\right)$$

$$V_{m}\left(\mathbf{r}\right) =-\mu _{\mathbf{n}}\cdot \mathbf{B}\left(\mathbf{r}\right)$$



Neutron Scattering

- Advantages
 - Sensitive for probing lighter atoms
 - Sensitive to isotopes
 - Highly-penetrating and typically non-perturbing
 - Can be used to probe the magnetic structure of samples
- Disadvantages
 - Expensive
 - Samples may become radioactive
 - Relatively lower flux and higher background

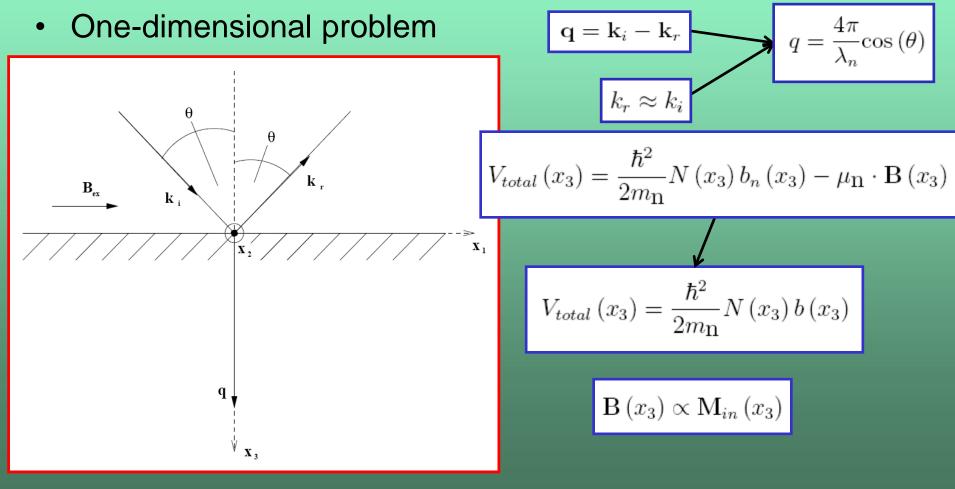
Polarized-neutron Reflection

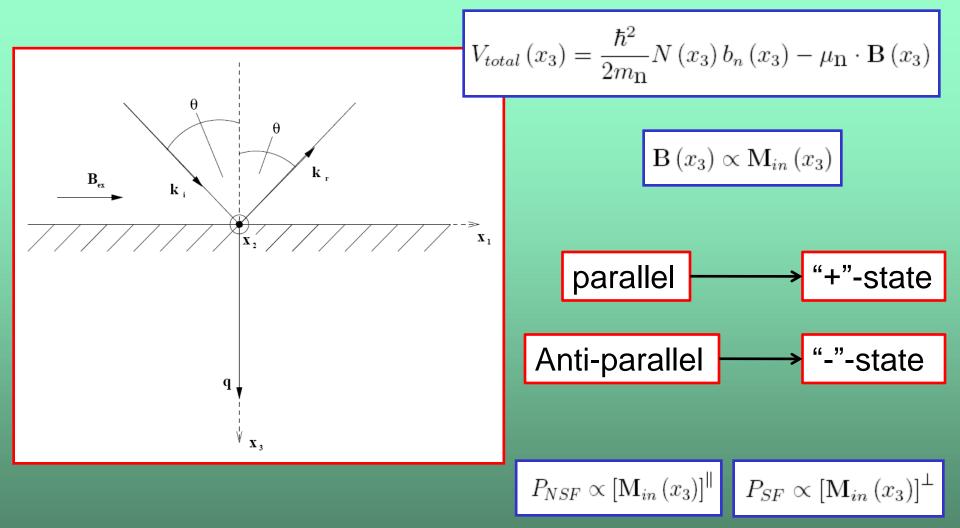
• Magnetization of ferromagnetic thin films

$$V_{total} \left(\mathbf{r} \right) \approx V_n + V_m$$
$$V_n \left(\mathbf{r} \right) = \frac{2\pi\hbar^2}{m_n} b_n \delta \left(\mathbf{r} \right) \qquad \qquad V_m \left(\mathbf{r} \right) = -\mu_n \cdot \mathbf{B} \left(\mathbf{r} \right)$$

- Polarized-neutron specular reflectometry
 - Depth profile of the magnetization
- Polarized-neutron off-specular reflectometry
 - Lateral information about the magnetization

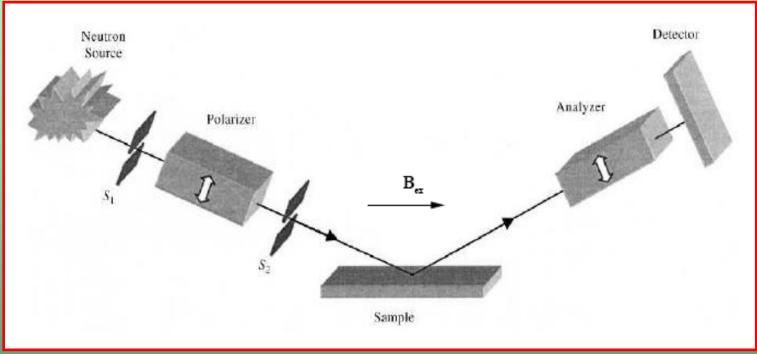
- Neutron magnetic dipole moment is aligned along B_{ex}
- Neutron is reflected at angle θ from a flat surface
- The transfer wavevector **q** is perpendicular to the surface





 Neutron magnetic dipole moment may flip when reflected from a ferromagnetic material of magnetization M

Experiment is carried out in a magnetic field

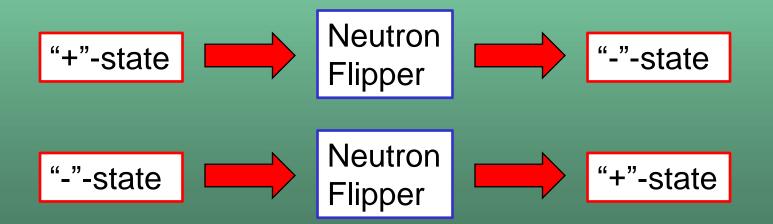


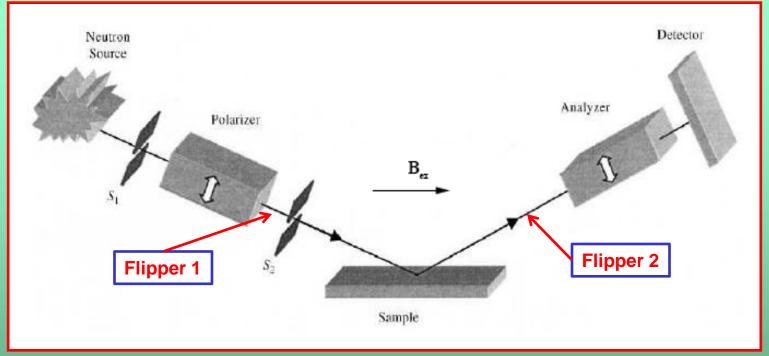
J.F. Ankner and G.P. Felcher, J. Magn. Magn. Mater. 200, 741, (1999).



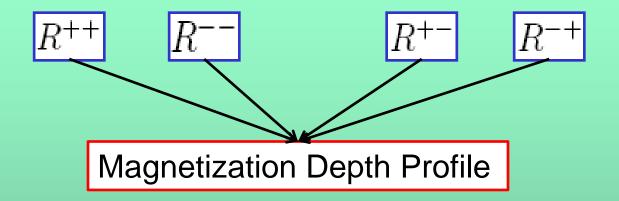


Use a neutron flipper to flip the polarization





Polarizer Orientation	Flipper 1	Flipper 2	Reflectance
+	No	No	R^{++}
+	Yes	No	R^{-+}
+	No	Yes	R^{+-}
+	Yes	Yes	$R^{}$



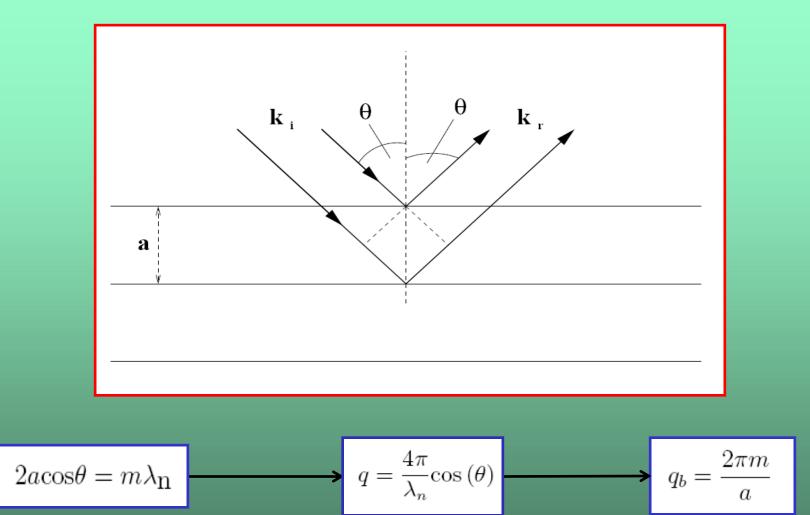
- $R(\mathbf{q})$ is the Fourier transform of the scattering length $b(x_3)$
- **q** can be probed by either varying the angle θ at fixed neutron wavelength λ or by varying λ at a fixed θ $q = \frac{4\pi}{2} \cos(\theta)$

$$V_{total}(x_3) = \frac{\hbar^2}{2m_{\rm n}} N(x_3) b(x_3)$$

$$V_{total}(x_3) = \frac{\hbar^2}{2m_{\rm n}} N(x_3) b_n(x_3) - \mu_{\rm n} \cdot \mathbf{B}(x_3)$$

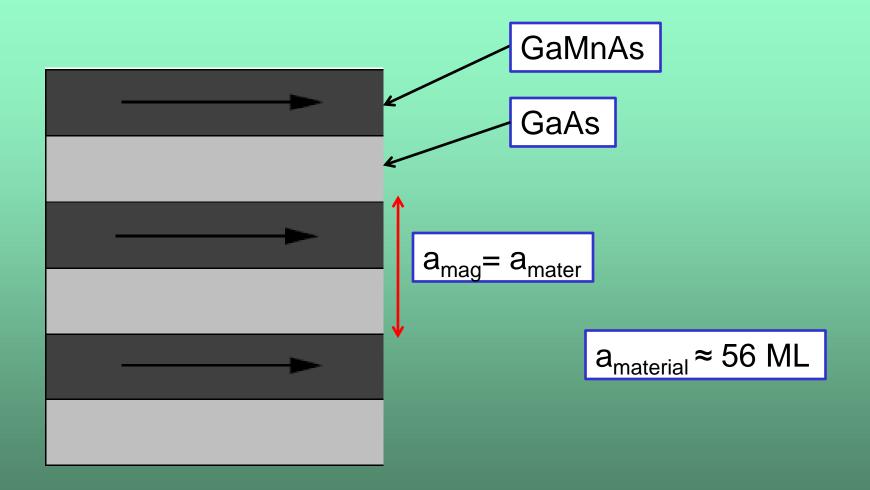
$$\mathbf{B}(x_3) \propto \mathbf{M}_{in}(x_3) \leftarrow \mathbf{M}_{in}(x_3) \leftarrow \mathbf{M}_{in}(x_3) = \mathbf{M}_{in}(x_3) \mathbf{M}_{in}(x_$$

Bragg Reflection



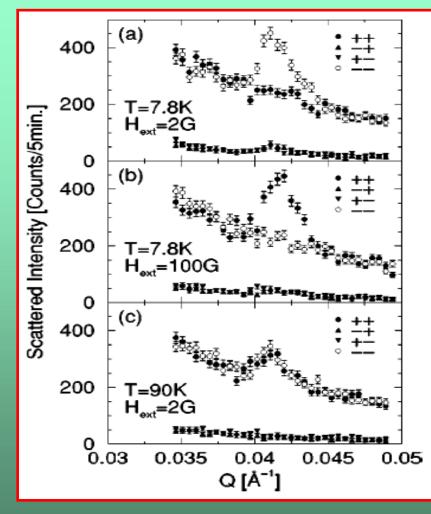
Preferential reflection at the Bragg wavevector

GaMnAs/GaAs Superlattice



Ferromagnetic coupling between the GaMnAs layers

GaMnAs/GaAs Superlattice



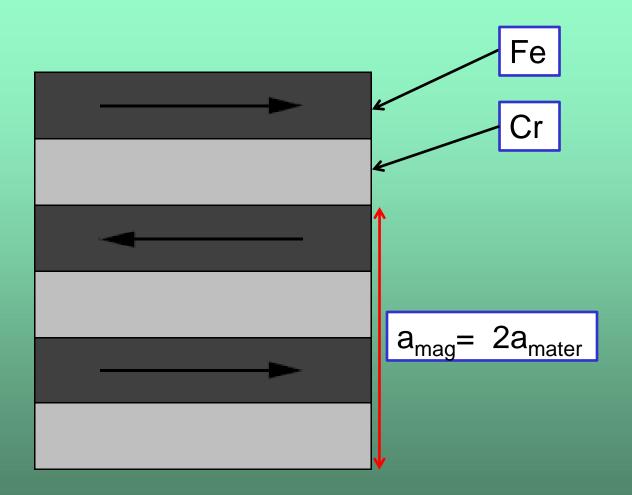
H. Kepa et al., Phys. Rev. B <u>64</u>, 121302, (2001).

$$V_{total}\left(x_{3}\right) = \frac{\hbar^{2}}{2m_{\mathrm{n}}} N\left(x_{3}\right) b_{n}\left(x_{3}\right) - \mu_{\mathrm{n}} \cdot \mathbf{B}\left(x_{3}\right)$$

$$\mathbf{a}_{mag} = \mathbf{a}_{mater}$$
$$q_b = \frac{2\pi m}{a}$$
$$P_{NSF} \propto [\mathbf{M}_{in} (x_3)]^{\parallel} \qquad P_{SF} \propto [\mathbf{M}_{in} (x_3)]^{\perp}$$

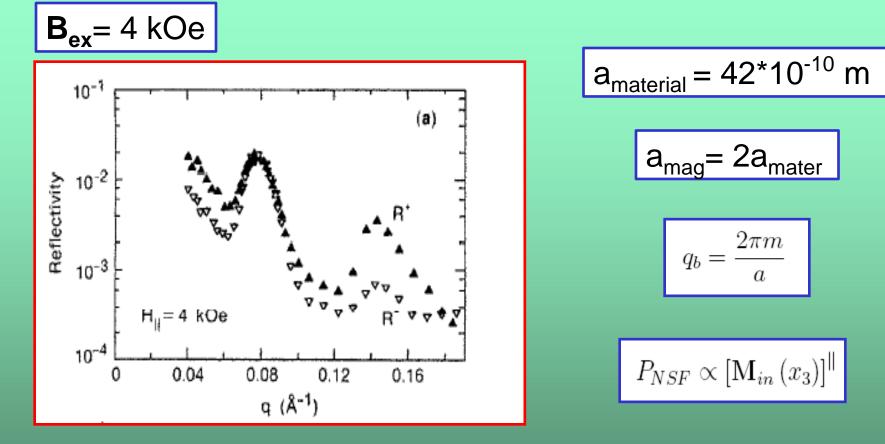
$$V_{total}\left(x_{3}\right) = \frac{\hbar^{2}}{2m_{\mathrm{n}}}N\left(x_{3}\right)b_{n}\left(x_{3}\right) \pm \mu_{\mathrm{n}}B\left(x_{3}\right)$$

Fe/Cr Superlattice



Anti-ferromagnetic coupling between the Fe layers

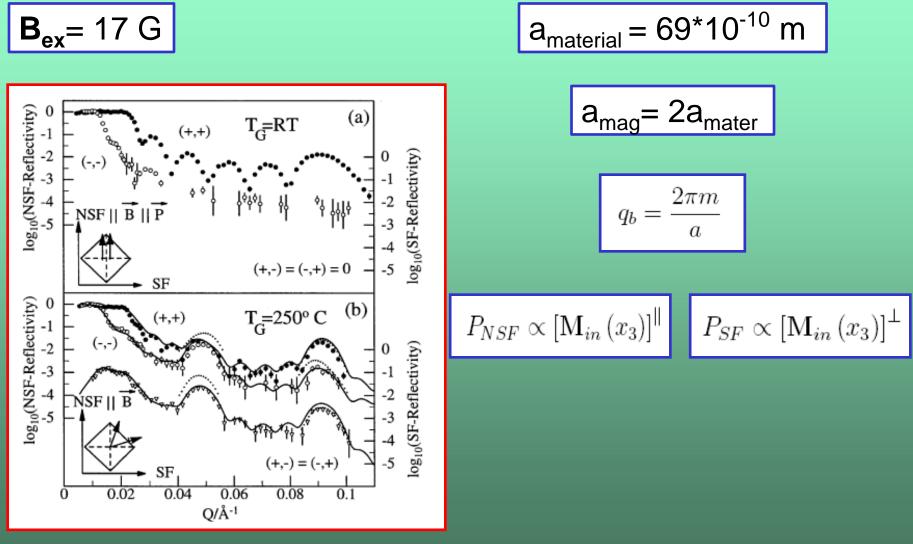
Fe/Cr Superlattice



S.S. P. Parkin, A. Mansour, and G.P. Felcher. Appl. Phys. Lett. 58, 14, (1991).

$$V_{total}\left(x_{3}\right) = \frac{\hbar^{2}}{2m_{\mathrm{n}}}N\left(x_{3}\right)b_{n}\left(x_{3}\right) - \mu_{\mathrm{n}}\cdot\mathbf{B}\left(x_{3}\right)$$

Fe/Cr Superlattice



A. Schreyer et. al Physica B 221, 366, (1996).

Summary of Results

- Polarized-neutron specular reflectometry can be used to obtain depth profiles of the magnetization of magnetic thin films
- Studies on GaMnAs/GaAs and Fe/Cr multilayered films have shown displayed peaks in intensity corresponding to the periodicity of magnetic interaction
- The effects of external magnetic field and temperature on the sample magnetization have been investigated